

Notice of References Cited	Application/Control No. 10/529,767		Applicant(s)/Patent Under Reexamination HAYAKAWA, TAKESHI	
	Examiner FRANKLIN S. ANDRAMUNO		Art Unit 2424	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,417,680	08-2008	Aoki et al.	348/333.05
*	B	US-7,228,061	06-2007	Mori et al.	386/95
*	C	US-7,237,029	06-2007	Hino et al.	709/227
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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